# 3. ANALYSIS OF TRACE ELEMENTS IN BASALTS BY SHIPBOARD X-RAY FLUORESCENCE SPECTROMETRY: A DISCUSSION OF NIOBIUM<sup>1</sup>

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### ABSTRACT

X-ray fluorescence spectrometry was used on board the *Glomar Challenger* during Leg 82 for analysis of "hygromagmaphile" trace elements that are useful to identify so-called "depleted" or "enriched" basalts; the results were used in choosing the new sites to be drilled on the basis of the "enriched" or "depleted" character of previous sites. This chapter describes a hitherto unpublished method for deducing concentrations from intensity measurements; the method yielded the precision (better than 1 ppm for Nb) necessary for purposes of the cruise.

The procedure for the matrix-effect correction is described. The case of Nb is discussed in detail because Nb concentrations in basalts are the lowest among the elements investigated (Nb, Zr, Ti, Y, V) and because it is the key element for deducing the enriched or depleted character of the different basalt units. Ta neutron-activation measurements made on shore after the cruise demonstrate, on the basis of the well-known constant Nb/Ta ratio in basalts, that the accuracy of the shipboard measurements of Nb concentrations in basalt units is about 0.5 ppm.

#### INTRODUCTION

Nine years after the first experimental X-ray Fluorescence (XRF) chemical analysis of rocks on board a research vessel during the GIBRACO cruise of the Jean Charcot (Bougault and Cambon, 1973), the XRF van provided by CNEXO3 was successfully used during DSDP Leg 82. Before that cruise, the XRF van had been used 12 times on board the Glomar Challenger since 1974 (Leg 37). On these earlier legs, the analyses were performed mainly to obtain the best descriptions of the different basalt units, based on major-element compositions and petrographic descriptions; these descriptions were then used as a guide in sampling for shore-based studies. The equipment, analytical procedures, and calculations used to derive major-element concentrations were described in Initial Reports Volumes 37 (Bougault, 1977); (Bougault, Treuil, et al., 1979; Natland et al., 1979); and 65 (Cambon et al., 1983). During some of these cruises (Legs 45, 55, 65, 69), the concentrations of some trace elements (Ni, Sr, Zr) were also measured to aid in describing the basalt units.

For Leg 82, as the cruise progressed, we had to select each site from a grid of 11 potential locations that were chosen ahead of time according to the objectives of the cruise: to examine mantle heterogeneity in the Azores Triple Junction area, away from the ridge axis, and along isochrons (see "Background and Objectives," this volume). The elements that can give information about mantle heterogeneity and that can be measured on board by X-ray fluorescence spectrometry are niobium, zirconium, titanium, yttrium, and vanadium. The behavior of each of these "hygromagmaphile" trace elements mimics that of a different rare earth element (REE). For example, Nb behaves like La (the lightest REE), and Zr behaves like Sm (an REE of medium atomic number); consequently, the ratio Nb/Zr can be used in place of La/Sm to determine the depleted or enriched character of the basalts (Schilling and Winchester, 1967; Bougault et al., this volume). Expressed in their most convenient form (normalized to chondrite), the ratios are nearly equal; that is, (Nb/Zr)<sub>ch</sub> is about equal to (La/Sm)<sub>ch</sub>. Thus, in addition to providing data for the best descriptions of basalt units through major-element and some trace-element abundances, the main objective of on-board XRF analyses during Leg 82 was to determine concentrations of those "hygromagmaphile" trace elements, which could be used as a basis for site selection consistent with the objectives of the cruise.

The concentrations of the pertinent hygromagmaphile elements are of the following orders of magnitude: Nb, 0-50 ppm, with a critical range of values for geochemical interpretation between 0 and 15 ppm; Zr, 50-200 ppm); Ti, 3000-15,000 ppm (the abundance of this element is obtained from the major-minor analytical procedure); Y, 15-45 ppm; and V, 150-450 ppm. From these ranges of concentrations, it is clear that Nb is the most critical element. We will examine and determine the accuracy

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and limits of detection through the statistics of counting rates, possible interferences, the matrix-effect correction that we have used, and standard concentrations.

# **MATRIX EFFECT**

The relationship between the concentration c and the intensity I emitted by an element in a sample irradiated by X rays is

$$I = \frac{Ac}{M}, \qquad (1)$$

where A is a constant and M the matrix effect. Usually, for a simple geometry of the spectrometer, the matrix effect M can be formulated by

$$M = \Sigma(\mu/\rho)_{pi} c_i + \Sigma(\mu/\rho)_{zi} c_i, \qquad (2)$$

where  $c_i$  is the concentration of an element *i*,  $(\mu/\rho)_{pi}$  the coefficient of absorption of the primary excitating beam by the element *i*, and  $(\mu/\rho)_{zi}$  the coefficient of absorption of the emitted beam (wavelength  $\lambda_z$ ) by the element *i*.

It is difficult in trace-element analysis to use a "buffer" glass disc, such as is used in major-element analysis; such a method would increase M (relative to the numerator in Eq. [1]) and thus diminish I, the sensitivity, and the limit of detection. As far as possible, for trace elements, the measurements have to be done on the rock powders themselves. The rocks are crushed in an agate mortar, and the powder is pressed into a pellet, using wax as a binder. This method of preparation, which is employed to obtain the best counting rate, limits the possibilities of contamination, and is simple and quick to use on board the ship. The same pellets can then be used on shore, either to verify on-board measurements or for additional determinations. But, because the matrix effect can vary by as much as a factor of 2, it is necessary to have a precise method of either calculating or measuring M, in order to calculate accurate concentrations of trace elements.

Among the three main methods that permit access to the value of the matrix effect are (1) use of standards that have the same major-element compositions as unknown samples; (2) measurement of the background or Compton peak (Anderman and Kemp, 1958; Champion et al., 1960; Clark and Mitchell, 1972; Cullen, 1962; Delong and McCullough, 1973; Feather and Willis, 1976; Hower, 1959; Hutton and Norrish, 1977; Johnson and Stout, 1958; Kalman and Heller, 1962; Leoni and Saitta, 1977; Nesbitt et al., 1976; Price and Angell, 1968; Reynolds, 1963, 1967; Sherman, 1955; Verdumen, 1977; Walker, 1973; Weber and Newbury, 1971; Wilband, 1975; Wyrobish, 1977); and (3) calculation of *M* from the major-element composition of each sample.

We chose the third one, because the major-element compositions had to be determined on board to be useful in preparing the best descriptions of the different basalt units. Nevertheless, we still have to prove that this method is practicable and attains the necessary precision. The matrix effect is the sum of two terms (Eq. [2]), one related to the primary excitating X-ray beam and the other to the beam emitted by the studied element in the sample, provided that the parameters accounting for the geometry of the instrument are integrated into the constant A in Equation (1).

When we know the wavelength of the beam absorbed by the sample, it is easy to find  $\mu/\rho$  from a table of mass-absorption coefficients. This coefficient  $(\mu/\rho)_{zi}$ , is straightforward for the emitted beam, because by definition its wavelength,  $\lambda_z$ , is known. But finding  $(\mu/\rho)_{pi}$ , corresponding to the excitating beam is much more difficult, because that beam is polychromatic; this is the classic problem of finding the "equivalent" wavelength that would induce the same fluorescence intensity as the polychromatic beam from the X-ray tube. We want to show that, in general, knowledge of the equivalent wavelength is not necessary for calculating the matrix effect from the major-element concentrations.

 $\lambda_z$  is the wavelength of X rays emitted by the element of atomic number z.  $\lambda_{AE}$  is the absorption edge of this element. For rock samples, the trace elements can be classified into two groups according to the value of  $\lambda_z$  or  $\lambda_{AE}$  with respect to Fe  $K_{AE}$  (Hower, 1959; Quintin, 1970; Reynolds, 1963); Fe is the major element with the highest atomic number:

1.  $\lambda_{AE}$  is higher than Fe  $K_{AE}$ : The pertinent elements for silicate rock samples are Sc, V, Cr, and Co.

2.  $\lambda_z$  is shorter than Fe  $K_{AE}$ : This is the general case if a K line can be excited.

In the second general case, the range of wavelengths that permit excitation of an element is necessarily out of the range of absorption discontinuities of major elements (Fig. 1). A trace element whose atomic number z is higher than 27 has a K absorption edge lower than Fe  $K_{AE}$ : the photons able to excitate this element have wavelengths shorter than  $\lambda_{AE}$ . Under these conditions, whatever the equivalent wavelength  $\lambda_p$ , the mass-absorption



Figure 1. Range of absorption edges for trace elements, referred to Fe  $K_{AE}$  (Fe being the major element with the highest atomic number). See text for discussion.

coefficient of the major element i with respect to the primary excitating beam can be written as

$$(\mu/\rho)_{pi} = \delta_i (\lambda_z)^{\gamma}. \tag{3}$$

This is the classic equation that shows the relationship between mass-absorption and wavelength;  $\delta_i$  is characteristic of the absorbing element and  $\gamma$  is a constant.

From Equation (2), the matrix effect M, which is a function of the primary beam (wavelength  $\lambda_p$ ), the emitted X rays (wavelength  $\lambda_z$ ), and the major elements (*i*) can be written as

$$M(\lambda_p, \lambda_z, i) = (\lambda_p)^{\gamma} \Sigma \delta_i c_i + (\lambda_z)^{\gamma} \Sigma \delta_i c_i, \text{ or}$$
$$M(\lambda_p, \lambda_z, i) = [(\lambda_p)^{\gamma} + (\lambda_z)^{\gamma}] \Sigma \delta_i c_i.$$
(4)

Whatever the value of the equivalent wavelength  $\lambda_p$ , we can write  $(\lambda_p)^{\gamma} = K(\lambda_z)^{\gamma}$  and deduce that

$$M(\lambda_p, \lambda_z, i) = (1 + K)(\lambda_z)^{\gamma} \Sigma \delta_i c_i = M(\lambda_z, i).$$
 (5)

This result can be expressed as follows: For a trace element whose emitted X rays are of a wavelength shorter than the absorption edge of the major element with the highest atomic number in the studied sample, the matrix effect is independent of the primary excitation X rays.

If a trace element z' meets the same requirement as z, it is also possible to write

$$(\lambda_{z'})^{\gamma} = K'(\lambda_z)^{\gamma}.$$
 (6)

This observation permits us to deduce that

$$M(\lambda_{z'}, i) = K'(1 + K)(\lambda_z)^{\gamma} \Sigma \delta_i c_i.$$
(7)

This relationship can be expressed in the following way: For two trace elements z and z' whose emitted X rays are of a wavelength shorter than the absorption edge of the major element with the highest atomic number in the studied sample, the ratio of the matrix effect for z'to the matrix effect for z is a constant.

With the conditions that have been given here for a trace element, the calculation of the matrix effect is thus, except for a constant, independent of the wavelength of the studied trace element. We note that that constant need not be known, because the constant A in Equation (1) has to be determined anyway, and the constant  $K'(1 + K)(\lambda_z)^{\gamma}$  can be implicitly included in A during the standardization procedure.

It is now possible to account for a second relationship between the mass-absorption coefficients and atomic numbers of the absorbing elements (the major elements in the sample):

$$(\mu/\rho)_i = \beta(z_i)^{\alpha}, \qquad (8)$$

where  $z_i$  is the atomic number of the absorbing major element *i* and  $\alpha$  and  $\beta$  are constants.

With this relationship, it is easy to deduce that

$$I = \frac{Ac}{M} = \frac{Ac}{\Sigma\beta(z_i)^{\alpha} c_i} = \frac{Ac}{\beta\Sigma(z_i)^{\alpha} c_i}.$$
 (9)

 $\beta$  is included in the constant A during standardization:

$$I = \frac{Ac}{\Sigma(z_i)^{\alpha} c_i}.$$
 (10)

This is the simple general relationship that exists between the intensity of X rays emitted by a trace element under the conditions mentioned, its concentration, and the matrix effect of the sample. In particular, this relationship applies for K emissions of trace elements in rocks whose atomic numbers are higher than 27, such as Nb, Zr, and Y. The concentrations of these elements were calculated during Leg 82 by using Equation (10).

The value of the constant  $\alpha$  can be determined from tables of mass-absorption coefficients (Leroux and Thin, 1977). Different values of  $\alpha$ , given in different tables, do not produce significant differences in the results for a wide range of rock compositions. An example is given in Table 1, where Rb and Nb concentrations have been calculated using  $\alpha$  values of 2.65 and 2.81.

### SHIPBOARD TRACE-ELEMENT ANALYSIS DURING LEG 82: A SPECIFIC APPROACH FOR NIOBIUM

For K emissions, the theoretical precision of determinations of trace-element concentrations is about 1 ppm. Even if there are other parameters to account for in determinating concentrations, such as instrumental interferences (Bougault et al., 1977) and spectral interferences (e.g., Y and V), the precision obtained is not generally critical for geochemical interpretation if the concentrations are higher than 20 or 30 ppm. An example is provided by Y, where the Rb  $K_{\beta}$  line interferes with the Y  $K_{\alpha}$ line. The results are given in Table 2. A general relationship accounting for instrumental and spectral interference (Rb  $K_{\beta}$ ) has been used:

$$(I - I_0)M = Ac + A' c' + B, \qquad (11)$$

where

- I = net intensity,
- $I_0$  and B = two parameters for instrumental interferences,

A = sensitivity for the studied element,

A' = sensitivity for the interfering element,

$$c$$
 and  $c'$  = the concentrations of the studied element  
and the interfering element, respectively.

From Figure 2 and the calculated Y concentrations in Table 2, it appears that the precision of about 1 ppm is not critical for geochemical interpretations for concentrations in basalts that range between 20 and 50 ppm.

Standard	Rb concentration			Nb concentration		
	Recommended	Calculated			Calculated	
		$(\alpha = 2.65)$	$(\alpha = 2.81)$	Proposed	$(\alpha = 2.65)$	$(\alpha = 2.81)$
AGV <sub>1</sub>	67	67.2	67.9	15.0	14.6	14.7
BR	45	45.2	44.8	114	114	115
BCR1	46	46.6	46.5	14.5	14.9	14.2
W1	21	21.8	20.9	8.5	9.0	8.3
DTS <sub>1</sub>	0	-0.6	-1.2	0.0	0.0	0.3
G <sub>2</sub>	169	170.0	171.0	11.0	10.1	10.7
GSP1	254	253.0	255.0			
PCC	0	0.1	-0.4	0.0	0.8	1.4
DRN	75	73.2	74.2	9.0	8.2	7.9
GH	390	390.0	389.0	85.0	85.0	84.0
GA				11.0	11.1	11.6
$r^2$		0.99994	0.99993		0.99979	0.99963
σ		0.33	0.34		0.19	0.25

Table 1. Influence of the choice of the value of  $\alpha$  on the calibration (concentrations in ppm).

Note: Rb and Nb concentrations have been calculated using  $\alpha$  values of 2.65 and 2.81 (see text). "Recommended" and "proposed" have the usual meanings as applied to concentrations for standards. A recommended value has a higher probability of being close to the true value than a proposed value.  $r^2$  = the correlation coefficient and  $\sigma$  = the standard deviation in ppm.

Table 2. Niobium: net intensities, matrix-effect values (M), and recommended and calculated concentrations of standards.

Hole-Core-Section (interval in cm)	Intensity	М	Nb conc. = 16Ta (ppm)	Nb. conc. (calculated (ppm)
Leg 55				
433C-10-4, 118-121	4160	122.08	6.9	5.9
433C-10-2, 58-60	8739	126.30	12.5	12.5
433C-14-3, 55-57	10,969	125.29	15.5	15.4
433C-32-1, 98-101	2914	117.69	4.3	4.1
Leg 69				
504B-19-2, 46-49	8091	112.93	9.9	10.4
504B-19-1, 73-77	10,664	114.47	13.6	13.8
504B-4-2, 52-58	116	115.40	0.3	0.5
Leg 70				
504B-56-1, 139-142	1825	118.50	2.6	2.7
Leg 65				
482D-10-3, 101-103	683	118.97	1.4	1.2
483-26-1, 128-130	2720	121.70	3.5	4.0

Note: IM = Ac + B; A = 90,954.29; B = -30,708.25. (See text for discussion.) Tube, Au; counter, NaI; crystal, LIF; collimator, 0°15; background counting time,  $4 \times 40$  s; peak counting time,  $4 \times 40$  s; peak, 21°34'; left background, 20°94'; right background, 21°72'.

Another example is given by V. There is a spectral interference with the Ti  $K_{\beta}$  line, Ti being a minor element, and even if V does not meet the theoretical requirements previously mentioned as regards K absorption edge versus Fe  $K_{AE}$  (we will not discuss the specific method used), the precision obtained at the end is comparable to that obtained for Y (Table 3, Fig. 3).

The examples of Y and V show that even when spectral interferences exist it is possible to attain a convenient accuracy, if the concentrations of the elements are higher than about 20 ppm. In the case of Nb, a specific problem exists for a range of concentrations between 0 and 15 ppm. In this range of concentrations, two addi-



Figure 2. Y calibration curve. Intensities (corrected for matrix effects) versus concentrations. The parameters A, A', B, and  $I_0$  are discussed in text. Data points correspond to geologic standards listed in Table 3. Corr. = corrected.

tional factors must be considered to avoid systematic errors that could be larger than the precision related to counting statistics. The first concerns the settings of the spectrometer (peak and background positions), and the second relates to knowledge of recommended concentrations of standards.

The setting of the spectrometer requires careful selection of peak and background positions to obtain a zero net intensity (peak minus background) for a blank (pure quartz, for instance). This zero intensity for zero concentration of Nb must then be checked in relation to the second factor (knowledge of standards) for a natural sample; this is to minimize possible interference with the tail of the Y  $K_{\beta}$  peak.

Table 3. Yttrium: net intensities, matrix-effect values (M), and recommended and calculated concentrations of standards.

Standard	Intensity	М	Recommended concentration (ppm) Y	Recommended concentration (ppm) Rb	Calculated concentration (ppm) Y
GH	23,5349	75.08	87	390	87.2
GA	76,369	81.94	21	176	22.2
PCC <sub>1</sub>	- 721	88.25	0	0	-0.9
DRN	41,542	109.3	26	75	27.4
BR	32,378	131.38	30	45	30.9
BCR1	40,119	124.98	40	47	38.1
AGV1	35,409	98.71	19	67	19.1
GSP1	97,384	89.00	29	254	28.3
G <sub>2</sub>	60,217	81.31	11	170	10.0
DTS <sub>1</sub>	979	90.26	0	0	0.6

Note:  $(I - I_0)M = AC + A'C' + B$ , A = 100,815.09; A' = 22,784.37; B = 154.591.34;  $I_0 = 2023.24$ . (See text for discussion.) Tube, Au; counter, Nal; crystal, LIF; collimator, 0°15; background counting time, 100 s; peak counting time, 2 × 100 s; peak, 23°73'; left background, 23°42'; right background, 24°08'.



Figure 3. V calibration curve. Intensities (corrected for matrix effects) versus concentrations. The parameters A, A', B, and  $I_0$  are discussed in text. Data points correspond to geologic standards listed in Table 4.

For Nb concentrations of standards, according to the last review of trace elements in rocks by Abbey (1980), no recommended Nb concentrations exist between 0 and 15 ppm, and there are none for higher concentrations, either; all values are "proposed" concentrations. The good fit in Table 1 between "proposed" concentrations and concentrations found with either  $\alpha = 2.65$  or  $\alpha =$ 2.81 demonstrates the coherence of the analytical method between 0 and 115 ppm. For these international standards, one observes that two of them are close to zero concentration, five are between 8 and 15 ppm, and the last two are between 85 and 114 ppm. Such a distribution of Nb concentrations in standards does not preclude a constant error of between 0 and 15 ppm, particularly if we keep in mind that the values in Table 1 are only "proposed."

To overcome the absence of well-known certified standards for Nb between 0 and 15 ppm, we will use the geochemical properties of the pair of elements Nb and Ta. A large number of samples, many of them DSDP samples, have been studied for these two elements. Nb con-

centrations were determined by XRF spectrometry using the calibration corresponding to values proposed in Table 1 (Bougault, 1980). Ta concentrations were measured through instrumental neutron activation analysis (INAA), using cadmium vials (Jaffrezic et al., 1977). These results demonstrate that the Nb/Ta ratio is constant in mid-ocean ridge basalts, from "depleted" to "enriched" types according to the "rare earths" definition (Bougault, Joron, et al., 1979). Since that last-mentioned study, the Nb/Ta value of 16 has been confirmed by analysis of several other samples from different geologic environments: seamounts in the North Pacific (Leg 55: Cambon et al., 1980) and volcanoes of "la chaîne des Puys" (El Azzouzi, 1981; El Azzouzi et al., 1982). The accuracy of Ta measurements by INAA, especially for low values, is much better than the accuracy of Nb determinations by XRF spectrometry. From these observations (constant Nb/Ta ratio in basalts and accuracies of Nb and Ta measurements), we were able to detect a systematic Nb overestimate of about 1 ppm for the lowest concentrations (between 0 and about 6 ppm). Taking this into account, it was possible to demonstrate that the constant Nb/Ta ratio in the most "depleted" basalts (Leg 65 and Legs 69 and 70, Hole 504B) is preserved (Cambon et al., 1983; Etoubleau et al., 1983), as shown in Figure 4. For Leg 82, we thus selected our own standards, whose Nb and Ta concentrations are well distributed (0 to 15 ppm for Nb; 0 to 1 ppm for Ta). Because the Ta accuracy is better than the Nb accuracy and the Nb/Ta ratio is constant in basalt rocks, we chose the Nb concentrations of selected standards to be 16 times the Ta concentrations: this was a better approximation to the true Nb concentrations than could be obtained through Nb measurements themselves.

We thus come to a set of standards of basalts whose Nb concentrations are between 0 and 15 ppm. The determination of these concentrations is based both on the determination from international standards and on the



Figure 4. Nb versus Ta concentrations. Filled circles correspond to the different basalt units encountered at 22°N on the East Pacific Rise during Leg 65; other symbols identified in key to figure.

constant Nb/Ta ratio in basalts. Some uncertainties can remain for true concentrations, but because Ta is determined with better precision than Nb, we are sure to have a correct classification (concentrations relative to each other).

In addition to this approach to developing standards with well-known Nb concentrations, the proposed method presents the two following advantages:

1. Even if the matrix effect is well calculated, as demonstrated by Table 1 for Rb and Nb, this method uses known basalt standards, which reduce the range of variation of the matrix effect; it varies here by about 10%, whereas it varies by a factor of 2 for the usual standards mentioned in Table 1.

2. A possible spectral interference, like the Y  $K_{\beta}$  line, should not be critical in this method when the same rock types are considered for standardization.

The calibration curves obtained on board are presented in Figures 5 and 6: net intensity versus Nb concentrations and matrix-effect-corrected intensity versus concentration, respectively. The standard deviations, indicated on each figure, demonstrate the efficiency of matrix-effect correction even within a narrow range of rock compositions. Net intensities and Nb concentrations of standards found from the calibration are indicated in Table 4; they correspond to a single measurement run. Instrumental settings and conditions of measurements are also mentioned in the footnote to Table 4.

The standard BR, whose proposed Nb concentration is 114 ppm, was used to check to stability of the instrument during Leg 82. The calculated Nb concentration from the parameters obtained by the calibration in Figure 6 (whose range is 0-15 ppm) was found to be 115 ppm. This value is in agreement with the values presented in Table 1 and is a guarantee of self-consistency between high and low Nb concentrations.



Figure 5. Nb calibration curve: intensities (I) versus concentration (C).



Figure 6. Nb calibration curve: intensities (IM) (corrected for matrix effects) versus concentration (C).

Table 4. Vanadium: net intensities, matrix-effect values (M), and recommended and calculated concentrations of standards.

Standard	Intensity	М	Recommended concentration (ppm) V	Interfering element: recommended concentration Ti	Calculated concentration (ppm) V
BCR1	37,464	289.68	410	13,320	410
PCCi	3109	226.28	31	60	33
DTS	1306	222.06	9.5	60	8
GSP1	7141	284.71	49	3960	47
AGV1	13,768	282.15	118	6300	117
GA	5105	278.11	36	2280	40
GH	1087	274.04	5	480	4
BR	26,943	324.30	244	15,660	245
DRN	19,864	287.66	221	6600	221

Note:  $(I - I_0)M = AC + A'C' + B$ . A = 16,765.99; A' = 292.88; B = 332,599.72;  $I_0 = -877.17$ . (See text for discussion.) Tube, Au; flow counter; collimator, 0°15; crystal, LIF; vacuum; background counting time, 40 s; peak counting time, 2 × 40 s;  $2\sigma$  left background, 76°00';  $2\sigma$  right background, 78°20';  $2\sigma$  peak, 76°98'.

The stability of the instrument and the variation of calculated concentrations can also be evaluated in Figure 7. On this figure, the calculated Nb concentrations of the lowest (Leg 69: Sample 504B-4-2, 52-58 cm, 0.3 ppm) and the highest (Leg 55: Sample 433C-14-3, 55-57 cm, 15.3 ppm) standard are plotted versus time: 21 measurements for the highest standard and 25 measurements for the lowest, made on different days during Leg 82. The standard deviation calculated from both standards ( $\cong 0.7$  ppm) is consistent with the standard deviation from the calibration curve itself in Figure 6. This standard deviation represents one determination; repeated measurements of the same sample or of samples belonging to the same magmatic unit improve the precision. During Leg 82, two to about ten samples were analyzed for a given basalt unit; this gives a better precision than the standard deviation mentioned above. We



Figure 7. Calculated Nb concentration of the lowest standard (Leg 69, Sample 504B-4-2, 52-58 cm: 0.3 ppm) and the highest standard (Leg 55, Sample 433C-14-3, 55-57 cm: 15.3 ppm) versus time as the cruise progressed.

will consider that the Nb concentration of each basalt unit is known with an accuracy of between 0.8 and 0.3 ppm, according to the number of samples analyzed per unit.

Verification of the shipboard Nb measurements lies in the comparison to onshore INAA for Ta performed by J. L. Joron at "Laboratoire P. Sue du CNRS Saclay," because it has been well demonstrated that the Nb/Ta ratio is constant. Nb concentrations determined aboard ship are plotted versus these Ta concentrations in Figures 8 and 9. Figure 9 enlarges the area enclosed by dashed lines in Figure 8 (Nb varying between 0 and 10 ppm). The Nb/Ta ratio of 16 is well confirmed, and the dispersion of points around the straight lines of Figures 8 and 9 demonstrates that the Nb accuracy is better than the 0.8 ppm just mentioned.

Figure 10 is an example of interpreted data combining shipboard data (Nb, Zr, Ti, Y, and V) and onshore INAA data (Th, Ta, La, Hf, Tb). On the ordinate it represents the logarithm of the element concentration normalized to chondrites (Bougault et al., this volume) versus, on the abscissa, the (decreasing) values of hygromagmaphile character of the elements (Th to V). For Nb, the value 10 represents 5 ppm; because the objective of on-board analyses was to detect enriched and depleted samples, it is easy to understand why we had to be very cautious in measuring Nb concentrations.

## CONCLUSION

The strategy for conducting Leg 82 was largely based on geochemical results that could be obtained on board the ship. The elements of interest, those that make possible identification of so-called "enriched" or "depleted" basalts, and whose concentrations could be measured by XRF spectrometry on board, are trace elements, with ranges of concentration between 0 and 300 ppm. A special case is represented by Nb, because its concentration is low in basalts (most of the values are between 0 and 15 ppm), and it can be considered a key element in deducing the "enrichment" or "depletion." Special care was taken in analyzing for this element, both to improve the statistics and to minimize the possible systematic errors.



Figure 8. Nb concentration (shipboard determination) versus Ta concentrations (on-shore determination). The different symbols stand for the individual Leg 82 sites.

Shipboard Nb measurements have been verified on shore through Ta INAA, taking advantage of the constant Nb/Ta ratio in basalts. It has been proven that the accuracy of Nb concentration in each basalt unit as determined on board is better than 1 ppm. The accuracy depends upon the number of analyzed samples per basalt unit; a good estimate is 0.5 ppm.

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Figure 9. Nb versus Ta concentrations: enlargement of the area within the dashed lines on Figure 8. Symbols as in Figure 8; cross indicates theoretical precision.



Figure 10. Extended Coryell-Masuda plot obtained for Site 558. On the Y axis is plotted the logarithm of the concentrations normalized to chondrite concentrations. On the X axis the elements are positioned according to their affinity for the liquid phase of the magma, on a scale defined by the continuous variation of this property of rare earth elements.